

PATENT APPLICATION

of

Jukka-Pekka Vihmalo

Marko T. Ahvenainen

And

Jakke Mäkelä

for a

MEMORY WEAR LEVELING

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Field of the Invention

- This invention generally relates to a memory wear leveling and more specifically to reducing wearing of hotspots (memory blocks used more frequently) by rotating the memory blocks on the physical level based on predetermined criteria using at least one spare memory block.

Background of the Invention

- Conventional memories (e.g. flash memories) deteriorate somewhat on each write operation (destructive write). This may cause problems if certain memory areas are written more often than other areas. This problem can be solved by maintaining registers that count the number of write operations performed for each memory block. The least used block is then selected as the next block to be used when data is written (so called "wear leveling"). Solutions for wear levelling are used, for example, in flash memories. These implementations typically use tables to store usage of given sectors. Typically, there are some spare blocks, which can be taken into use, and old blocks (memory blocks that have been written too many times) can be removed from use (i.e. marked as "not in use") as they wear out. An example of such wear management approach for the write operation during memory usage can be found in US Patent 6,405,323, "Defect Management for Interface to Electrically-Erasable Programmable Read-Only Memory", by F. F.-L. Lin et al.; US Patent No. 5,568,423, "Flash Memory Wear Leveling System Providing Immediate Direct Access to Microprocessor", by E. Jou, et al.; and US Patent No. 6,230,233, "Wear Leveling Techniques for Flash EEPROM Systems", by K. M. J. Lufgren et al. Cache routines can also be used to solve this problem as described in US Patent Application No. 20010002475 "Memory Device" by L. I. Bothwell et al. Although technologies with destructive writes can be handled relatively easily with existing wear leveling algorithms, the same methods cannot be used for technologies with destructive reads discussed below.

Ferro-electric memories (FeRAM) are based on various ferroelectric compounds, e.g. a Perovskite compound $\text{Pb}(\text{Zr,Ti})\text{O}_3$ (PZT). The ability of a ferroelectric crystal to switch between its polarization states and to make a small area of reversed domains with fast switching has made ferroelectrics attractive for high capacity nonvolatile memories and data storage. The information can be written and read very fast requiring very little power; however, it has a limited life and suffers from a destructive read because of a fatigue factor, which is a degradation of the polarization hysteresis characteristic with increasing number of cycles. This is the most serious problem of ferroelectric memory devices in non-volatile memory applications. From a practical point of view, a lifetime (that is, the time until the polarization degradation is observed) of well over 10^{15} cycles is required which cannot be met by the current state-of-the-art ferroelectric memory technologies. The wear-leveling problem is thus expanded to read operations as well. The destructive read characteristic is a problem especially in hotspots. A hotspot is a memory block that is accessed significantly more often than memory blocks that are accessed on average. These hotspots are a problem when the memory read and/or write endurance is limited, which is the case with most solid-state nonvolatile memories.

There are several approaches to solving this problem for the read operation during memory usage. US Patent Application No. 20030058681, "Mechanism for Efficient Wearout Counters in Destructive Readout Memory", by R. L. Coulson, published March 27, 2003, presents a method utilizing wearout counters somewhat similar to those used in conventional memories for the write operation. US Patent Application No. 20010054165, "Memory Device Having Redundant Cells", by C. Ono, published December 20, 2001, describes a method utilizing redundant memory blocks as spare blocks for blocks that wear out. All of these methods require counting of access activities which increases overall complexity and overhead. EP Patent No. 0741388, "Ferro-Electric Memory Array Architecture and Method for Forming the Same", by J-D. D. Tai, published November 6, 1996, discloses an architecture that reduces the number of memory cells being accessed in a read operation.

Summary of the Invention

The object of the present invention is to provide a memory wear leveling methodology for reducing wearing of hotspots, i.e., frequently used memory blocks, in all memory types.

The hotspots are "smoothed out" by rotating the memory blocks on the physical level with the help of a spare memory block. This simple principle is illustrated by the example below, wherein 1,2,3,4... represent memory blocks and s represents the spare block. Then during each read operation the spare block switches places with the neighboring memory block as follows:

1234567890s,

123456789s0,

12345678s90,

15 1234567s890,

and so on. The present invention uses a blind approach in which no information about the actual memory usage is needed.

More generally, according to a first aspect of the present invention, a method for wear leveling of a multi-block memory containing data, usable in multi-block memory activities, comprises the steps of: detecting an at least one triggering signal; and copying or relocating the data of an at least one first memory block containing an at least one memory element of the multi-block memory to an at least one second memory block of the multi-block memory after detecting the at least one triggering signal, wherein said at least one second memory block does not contain said data before said copying or relocating. Further, each of the at least one first memory block and the at least one second memory block may contain only one memory element.

Still further, there may be more than one memory element contained in the at least one first memory block and there may be more than one memory element contained in the at least one second memory block, respectively.

5 In further accord with the first aspect of the invention, the method may further comprise the step of updating a first memory pointer originally pointed to the at least one second memory block before said copying or relocating to point to the at least one first memory block after said copying or relocating. Still further, the method may further comprise the step updating a second memory pointer by shifting it back to a physical zero point by reducing the value of the second memory pointer by a number
10 of relocated memory elements of the second memory block if the first memory pointer is pointing to one of the memory elements of the at least one second memory block after said updating.

Still further according to the first aspect of the invention, the data of an at least one additional block of the multi-block memory may be relocated to an at least one
15 further additional block of the multi-block memory after detecting the at least one triggering signal, wherein said at least one further additional block does not contain the data before said relocation.

Further still according to the first aspect of the invention, said copying or relocating may be performed according to predetermined criteria. Further, said
20 predetermined criteria may enable said copying or relocating of a regular pattern such that after a predetermined number of triggering signals copying or relocating steps are identical. Still further, said predetermined criteria may enable said copying or relocating of a random pattern such that after any number of triggering signals, copying or relocating steps are not necessarily identical.

25 In further accordance with the first aspect of the invention, said copying or relocating of the data may occur only after detecting a predetermined number of the at least one triggering signal.

Yet further still according to the first aspect of the invention, the at least one triggering signal may correspond to a read operation, to a write operation, to a time

clock pulse or to the detection of a predetermined number of read/write operations or clock pulses.

According further to the first aspect of the invention, said copying or relocating of the data may occur a predetermined number of times between the
5 triggering signals

According still further to the first aspect of the invention, the method may further comprise the step of counting the usage of the individual memory blocks of the multi-block memory, wherein said copying or relocating is performed according to predetermined criteria, said predetermined criteria includes considerations for said
10 counting.

According further still to the first aspect of the invention, all the data contained in the multi-block memory may be copied or relocated at the same time.

Yet still further according to the first aspect of the invention, the method may further comprise the step of updating a variable logical address X after said copying or relocating in the multi-block memory containing C memory elements, said variable
15 logical address X for said C memory elements identified by pointers $X_0, X_1 \dots X_k, X_{k+1} \dots X_{C-1}$ is updated to an updated variable logical address X_u for C-S memory elements identified by the pointers $X_0, X_1 \dots X_{k-1}, X_{k+S} \dots X_{C-1}$, wherein C is a total number of the memory elements of the multi-element memory, S is a number of the memory
20 elements identified by the pointers $X_k, X_{k+1}, \dots X_{k+S-1}$ in a spare memory block after said copying or relocating, wherein a first element of said first memory block after said copying or relocating corresponds to a first element identified by the pointer X_k of the spare memory spare block after said copying or relocating.

According to a second aspect of the invention, an electronic device,
25 comprises: a multi-block memory containing data, usable in multi-block memory activities; a memory wear controller, responsive to a triggering signal or to a further triggering signal, for providing a data-relocation signal to the multi-block memory to relocate the data from an at least one first memory block containing an at least one memory element of the multi-block memory to an at least one second memory block
30 of the multi-block memory wherein said at least one second memory block does not

contain said data before said copying or relocating, and for providing an update signal after performing said copying or relocating; and a memory pointer controller, responsive to the update signal. Further, each of the at least one first memory block and the at least one second memory block may contain only one memory element.

- 5 Still further, there may be more than one memory element contained in the at least one first memory block and there may be more than one memory element contained in the at least one second memory block, respectively.

- According further to the second aspect of the invention, the memory pointer controller may provide a pointer signal to the memory wear controller based on
10 predetermined criteria. Further, the memory pointer signal may contain a physical address in the multi-block memory to be accessed for enabling an at least one further data relocation of the data located at the physical address and optionally an address of a first memory pointer.

- Further according to the second aspect of the invention, the memory pointer
15 controller may provide updating of at least one memory pointer pointing to said first memory block before said copying or relocating to point to said second memory block after said copying or relocating.

- Further still according to the second aspect of the invention, the memory wear controller and the memory pointer controller may be implemented as software,
20 hardware, or a combination of software and hardware components. Further, the hardware may be implemented using a finite state machine.

- In further accord with the second aspect of the invention, said copying or relocating of the data from the at least one first memory block and updating the location of the memory pointers may be performed according to predetermined
25 criteria.

Further still according to the second aspect of the invention, the electronic device may further comprise a triggering detector, responsive to the triggering signal, for providing a further triggering signal upon detecting the triggering signal.

In further accordance with the second aspect of the invention, the electronic device may further comprise of a triggering detector, responsive to the triggering signal, for providing a further triggering signal upon detecting the triggering signal.

According to a third aspect of the invention, an electronic device comprises:

5 means for containing data in multiple memory blocks, wherein said data is usable in activities of the means for containing data; means for providing a data-relocation signal to the means for containing the data for copying or relocating the data from an at least one first memory block containing an at least one memory element of the means for containing the data to an at least one second memory block of the means

10 for containing the data in response to a triggering signal, wherein said at least one second memory block does not contain said data before said copying or relocating, and for providing an update signal on a status of the means for containing the data after performing said copying or relocating; and means for providing to the means for providing the data-relocation signal, in response to the update signal, a pointer signal

15 containing a physical address pointer in means for containing data to be accessed for enabling an at least one further data relocation of the data located at the physical address and optionally an address of a first memory pointer. Further, the means for providing to the means providing the data-relocation signal may further provide updating of at least one memory pointer pointing to said first memory block before

20 said copying or relocating to point to said second memory block after said copying or relocating.

According to a fourth aspect of the invention, a method for wear leveling of a multi-block memory containing data, usable in multi-block memory activities, comprises copying or relocating the data from an at least one first block containing an

25 at least one memory element of the multi-block memory to an at least one second block containing an at least one memory element of the multi-block memory after detecting a triggering signal related to said data, wherein said at least one second block does not contain said data before said copying or relocating. Further, an at least one memory pointer pointing to said first memory block before said copying or

30 relocating may be updated to point to said second memory block after said copying or relocating.

Brief Description of the Drawings

For a better understanding of the nature and objects of the present invention, reference is made to the following detailed description taken in conjunction with the following drawings, in which:

- 5 Figures 1a, 1b, 1c, and 1d together illustrate the concept of a multi-block memory wear leveling, according to the present invention.

Figures 2a, 2b and 2c together further illustrate the concept of a multi-block memory wear leveling comparing an actual memory space with a memory space seen by a user, according to the present invention.

- 10 Figure 3 is a block diagram representing a system for implementing a memory wear leveling, according to the present invention.

Figure 4a shows a flow chart for general implementation of a memory wear leveling, according to the present invention.

- 15 Figure 4b shows a flow chart of simplified Y-implementation procedure for general implementation of a memory wear leveling of Figure 3a, according to the present invention.

Figure 5 shows a flow chart for special implementation of a memory wear leveling with $S=1$, according to the present invention.

- 20 Figure 6 is a block diagram representing a hardware implementation of a memory wear leveling, according to the present invention.

Best Mode for Carrying Out the Invention

To assist in clarifying the technical subject matter of this invention, a few symbols are defined in Table 1 and further described in the text.

TABLE 1

Symbol	Description	Reference Figure
Z_0	A physical zero address/pointer, which is always zero and pointing to the first memory element of the memory space 10 or 10u .	Figs. 1a-1d, Fig. 2a-2c.
z	A logical zero address/pointer; it is also called a second memory pointer.	Figs. 1a-1d,
M	A spare block address/pointer; it is also called a first memory pointer.	Figs. 1a-1d, Fig. 2a.
C	A size of the memory 10 (a total number of the memory elements).	Fig. 1a.
S	A size of the spare memory block 18 (a total number of the memory elements in the spare block).	Fig. 1a.
X	A variable logical address of a memory element in the actual memory 10 .	Figs. 1b-1c, Fig. 2a.
X_0, X_2, \dots, X_{C-1}	Logical pointers of the memory elements in the memory 10 .	Fig. 2a.
U	A variable logical address of a memory element in the memory space 10u seen by the user.	Fig. 2b.
$U_1, U_2 \dots U_k$	Logical pointers of the memory elements in the memory space 10u seen by the user.	Fig. 2b.

X _v	An updated variable logical address of a memory element in the virtual memory space 10v.	Fig. 2c.
V ₁ , V ₂ ... V _k	Logical pointers of the memory elements in the virtual actual memory space 10v.	
Y	A variable physical address/pointer of a memory element in the memory 10; it points to the first element of a memory block (e.g., block 17) to be relocated to a spare block (e.g., block 18).	Figs. 1b-1c.
T	A variable used for calculating Y.	Figs. 4a, 4b, 5.
YY	A variable used for calculating Y.	Fig. 5.

This invention describes a memory wear leveling for reducing wearing of hotspots (memory blocks used more frequently) in all memory types by rotating the memory blocks on the physical level with the help of at least one spare memory block using predetermined criteria during or after read and/or write operations. The hotspots are smoothed out by this rotation. The present invention uses a blind approach in which no information about the actual memory usage is needed. The invention can be implemented, for example, by using constant memory pointers at a logical level and dynamic memory pointers on the physical level. The rotation can be implemented as a combination of software and hardware functionalities. For example, the physical rotation can be handled independently by a memory management hardware module, whereas logical and physical addresses are associated by a software method that calculates the physical address on the basis of the logical address and memory parameters. Another implementation alternative is using hardware for both memory rotation and address management. In this case, the hardware maintains the correct associations between the logical and physical addresses.

The advantages of the present invention are simplicity and a smaller overhead (i.e. memory reserved for memory management). Using counter registers as in conventional solutions for the write operation will result in a more complex memory management scheme than the present invention.

5 Figures 1a through 1d together show an example illustrating the concept of a multi-block memory 10 wear leveling, according to the present invention. A linear combination of memory blocks is chosen in Figures 1a through 1d for this illustrative example, but the memory 10 can also be represented by a "circular" combination of blocks as partial segments of a circle. The general case is in principle a
10 straightforward extension of the preferred implementation shown herein, but the general case requires additional steps and considerable complexity with no real advantage over the preferred embodiment.

Figure 1a shows the initial state of a memory array 10 shown as the linear combination of the memory blocks including, for example, a block 18, wherein C is
15 the total size (a total number of the memory elements) of the multi-block memory 10, M is a spare block address/pointer or a first memory pointer which typically points at the first element of the spare memory block 18 (or the spare block 18), S is a number of memory elements in the spare memory block 18, Z_0 is a physical zero address/pointer, and Z is a logical zero address/pointer or a second memory pointer. A
20 typical memory element has 16 bits or 2 bytes of information, but it can also be a memory cell or an array of memory cells or any other entity capable of containing at least one bit of data. Any memory block of the multi-element memory 10 (including the spare block 18) can contain one or more such memory elements. The physical zero address/pointer Z_0 points to the first available element of the memory 10 in a
25 preferred embodiment (and is therefore by definition equivalent to zero), and it does not change in time. This gives the memory 10 a convenient common reference point independently of the state of rotation.

For the example of Figure 1a, the spare block 18 is located just behind the logical zero address/pointer Z. The spare block can be a single or a multi-element
30 block. According to the present invention, it is recommended to choose C, Z_0 and Z such that quantities C and $Z - Z_0$ are divisible by S.

Figure 1b shows shifting of a first memory block 17 (or block 17) indicated at its start at the first element by a variable physical address/pointer Y to the spare block 18 (or the second memory block 18). Apparently, the blocks 17 and 18 have the same number of memory elements. A variable physical address/pointer Y is determined using a variable logical address X based on the predetermined criteria. According to one embodiment of the present invention, after each data relocation, the variable logical address X is altered by the amount equal to S or a multiple of S . For the presented example, a logical-to-physical memory mapping is given by a relationship $Y = Z_0 + (Z + X) \bmod C$. Since $Z_0 = 0$ and if the first value of $X = 0$, then $Y = Z_0 + Z = Z$, which is shown in Figure 1b. Thus, the block 17 starting at the logical zero address/pointer Z is relocated to the spare block 18. Generally, as evident from the above description, moving of the spare block is effectively done by writing the data of the memory block, which is to become the spare block to the current spare block. Alternately, copying instead of relocating of the content of the block 17 to the block 18 can be used, such that during a further relocating (copying) event, unusable data left in the block 17 (which becomes a new spare block after said previous relocation) is simply overwritten.

Figure 1c illustrates updating the first and second memory pointers M and Z , respectively, after the block 17 is relocated to the spare block 18 in Figure 1b. The first memory pointer M as shown in Figure 1c is moved to a location corresponding to the beginning of the block 17 (last relocated block) before the block 17 was relocated. Thus M again points at the spare memory block. After moving the first memory pointer M , the location of M is the same as the location of the second memory pointer Z in Figure 1a. The second memory address/pointer Z is then shifted back towards the physical zero address/pointer Z_0 by reducing the value of Z by the amount equal to the number of memory elements in the spare memory block S . A new location of Z is shown in Figure 1c. Generally, the criteria for updating M and Z after data relocation can be summarized as follows: a) always move M to a starting memory element of a new spare block; and b) move Z by the amount equal to S towards Z_0 in the direction of reducing Z if $M = Z$ or points to any memory element of the relocated block except the first memory element.

The same procedure described in Figures 1b and 1c is repeated multiple times by incrementing X by S , which is illustrated in Figure 1d, until M again reaches Z , at which point Z again becomes switched as shown in Figure 1c, described herein.

Figures 2a, 2b and 2c together further illustrate the concept of a multi-block memory wear leveling comparing an actual memory space with a memory space seen by a user and a virtual actual memory space, according to the present invention. Figure 2a shows the actual physical memory space of the memory 10 after a relocation memory event described herein. It consists of C memory elements indicated by logical pointers $X_0, X_1 \dots X_k \dots X_{C-1}$. The spare memory block includes S memory elements indicated by the logical pointers X_k through X_{k+S-1} , with the pointer M pointing at the first element X_k of the spare memory block. Figure 2b shows the memory space 10u seen by the user. It consists of $C-S$ memory elements indicated by logical pointers $U_0, U_1 \dots U_k \dots U_{C-S-1}$. The user does not see any of the spare blocks moving activity and the address space is totally constant and contiguous is far as the user is concerned. Thus, when the user specifies a variable logical address U indicated by the logical pointer U_k in the memory space 10u, the variable logical address X of the memory element in the memory space 10 is determined as follows:

$$X = U \text{ if } k < M, \quad (1)$$

$$X = S + U \text{ if } k \geq M. \quad (2)$$

The above relationship is important for establishing connection between memory spaces 10 and 10u and for the practical implementation of the present invention. This concept is further developed in Figure 2c showing a virtual actual memory space 10v with an updated variable logical address X_v recalculated using Equations 1 and 2 with $X_v = X$ every time after a memory block relocation event described herein. The virtual actual memory space 10v contains $C-S$ memory elements identified by pointers $X_0, X_1, \dots, X_{k-1}, X_{k+S}, \dots, X_{C-1}$, which is identical to the elements in the memory space 10u seen by the user. The elements identified by the pointers X_0, X_1, \dots, X_{k-1} in the memory space 10v correspond to the elements $U_0, U_1 \dots U_{k-1}$ in the memory space 10u, and the elements identified by the pointers X_{k+S}, \dots, X_{C-1} in the memory space 10v correspond to the elements $U_k, U_{k+1} \dots U_{C-S-1}$ in the memory space 10u, respectively. Figure 2c also shows (in parentheses) a new

set of logical pointers $V_0, V_1 \dots V_k \dots V_{C-S-1}$ in the virtual memory space $10v$, such that the virtual memory space $10v$ simulates the memory space $10u$ seen by the user. If, for example, after a subsequent relocation event the spare memory block is indicated by logical pointers X_{k+S} through X_{k+2S-1} , the virtual actual memory space $10v$ will contain C-S memory elements identified by pointers $X_0, X_1, \dots, X_{k+S-1}, X_{k+2S}, \dots, X_{C-1}$ again identical to the elements in the memory space $10u$ seen by the user. Figure 3 is a block diagram representing a system or an electronics device 11 for implementing a memory wear leveling, according to the present invention. Generally, the system 11 consists of a multi-block memory 10 containing data and responsive to a triggering signal 26 related to the data. A triggering event causes the triggering signal 26 to be activated. Such a triggering event can be a read or write operation or a clock pulse. Alternatively, the triggering event may be the occurrence of a counter reaching a certain value, the counter counting, for example, read/write operations or clock pulses. Alternatively, the triggering event can be some other occurrence that is dependent or independent of the data.

As shown in Figure 3, a triggering detector 20 (optional) is also responsive to the triggering signal 26, and upon detecting said triggering signal 26 provides a further triggering signal 26a to a memory wear block 22. The memory wear controller 22 provides a data-relocation signal 30 for enabling the data relocation to a spare block according to the predetermined criteria as described in the example of Figures 1a through 1d. The memory wear controller 22 also provides an update signal 32 on a status of the multi-block memory 10 after performing said relocation to a memory pointer controller 24. The status information includes new locations of the first memory pointer M after the relocation.

In general, the memory wear controller 22 provides a data-relocation signal 30 to the multi-block memory 10 in response to the further triggering signal 26a, which corresponds to the triggering signal 26 or it can respond directly to the triggering signal 26 if the triggering detector 20 is not used. However, according to the present invention, there are many variations. For example, the data-relocation signal 30 can be sent only after detecting a predetermined number (e.g., more than one) of the triggering signals 26 or the further triggering signal 26a. Alternatively, the data-

relocation signal 30 can be sent a predetermined number of times between the triggering signals 26 or the further triggering signal 26a. It is also possible that the triggering signal 26 is only conveyed to the triggering detector 20 and not to the multi-element memory 10.

5 The memory pointer controller 24, in response to the update signal 32, provides a pointer signal 34 to the memory wear controller 22. Said pointer signal 34 contains a physical addresses Y and optionally M in the multi-block memory 10 based on the predetermined criteria to be accessed for enabling at least one further data relocation of the data located at the physical address Y as described in the example of Figures 1a through 1d. The predetermined criteria includes considerations
10 discussed in regard to Figures 2a-2c and Equations 1 and 2. The first and second memory address/pointers M and Z, respectively, are updated internally in the memory pointer controller 24 after each memory block relocation. The address M can be incorporated in the pointer signal 34 depending on the system implementation, e.g., if
15 the block 22 does not update and hold information on M by itself. In addition the address M can be incorporated in the pointer signal 34 to provide a redundant protection (e.g., if the current value of M was lost in the block 22 because of the power failure, etc.) for increasing overall system robustness and reliability.

 The predetermined criteria which enables a relocation of data as disclosed in
20 the present invention can have many variations. For example, said relocation can have a regular pattern, such that after a predetermined number of triggering signals 26, relocation steps are identical. Said relocation, according to the predetermined criteria, can also have a random pattern, such that after any number of triggering signals 26, relocation steps are not necessarily identical. Furthermore, the method of the memory
25 wear leveling described in the present invention can be used in combination with conventional methods involving counting the usage of individual memory blocks of the multi-block memory 10 such that said predetermined criteria incorporates the counting information.

 The triggering detector 20, the memory wear controller 22, and the memory
30 pointer controller 24 of the system 11 shown in Figure 2 can be implemented as

software or hardware components or a combination of software and hardware components.

Figure 4a shows a flow chart, as one example among many others, for a general implementation example of a memory wear leveling, according to the present invention. In a method according to the present invention, in a first step 40, the initial values of parameters are set in the memory pointer controller 24. For example, the following initial parameters are set for this example: $Z_0=0$, $X=0$, $M=Z-S$, $(C-S) \bmod C=0$. In a next step 42, the triggering signal 26 is detected by the triggering detector 42. Step 42 implies sending signals 28, 30 and 32 as shown in Figure 3.

In a next step 44, it is ascertained whether the current value of X is pointing at a memory element within the spare block 18. If that is the case, in a next step 46, the value of X is increased by S and the process proceeds to step 48. If, however, the current value of X is not within the spare block, the process proceeds directly to step 48, wherein the value $T=X+Z$ is calculated. A determination of the current value of Y according to the predetermined criteria is performed using Y -determination procedure 47. There are many ways to make this estimation. One general scenario, among many other possibilities, consists of steps 50 through 50g as shown in Figure 3a. Steps 50, 50b, 50c and 50f are logical operations, performed by the memory pointer controller 24, comparing values of M with parameters $Z-S$, $C-S$, T and $T \bmod C$ as indicated in Figure 4a, respectively. Steps 50a, 50d, 50e and 50g set respective values of Y based on the decisions made in steps 50, 50b, 50c and 50f.

Steps 50a, 50d, 50e and 50g are followed by a next step 52, in which a block $Y:Y+S$ (e.g., block 17 in Figures 1b) is relocated to a spare block $M:M+S$ (e.g., block 18 in Figure 1b). In a next step 54, a new value of M is assigned: $M=Y$ setting a new value for the first memory pointer, as described in regard to Figure 1c. In a next step 56, it is ascertained whether a current value of M is within the block $Z-S:Z$. If that is the case, in a next step 58, the value of Z is reduced by S setting a new value for the second memory pointer, as described in regard to Figure 1c, and the process goes to step 60. If, however, the current value of M is not within the block $Z-S:Z$, in a next step 60, the value of X is increased by S . After step 60, the process returns to step 42.

Figure 4b shows a flow chart of a simplified Y-determination procedure **47a** for the general implementation of the memory wear leveling of Figure 3a, according to the present invention. The procedure **47a** consisting of steps **50** through **50d** is shown in Figure 3b. Steps **51a** and **50c** are logical operations performed by the
 5 memory pointer controller **34**, comparing values of **M** with parameters **Z**, **Y** and **T** as indicated in Figure 4b. Steps **51**, **51b** and **51d** set respective values of **Y** indicated in Figure 4b based on the decisions made in steps **51a** and **50c**.

Figure 5 shows a flow chart of one possible scenario among others for a special case of implementation of a memory wear leveling with $S=1$, according to the
 10 present invention. Steps **40a** through **48a** and **52a** through **60a** in Figure 5 are identical to steps **40** through **48**, and **52** through **60** with $S=1$ in Figure 3a. Y-determination procedure **47b** consisting of steps **53** through **53c** is shown in Figure 4. In a step **53**, a new parameter **YY** is calculated as $YY = T \bmod C$. In a next step **53**, it is ascertained whether **YY** is equal to **M**. If that is the case, in a next step **53b**, the value
 15 of **YY** is recalculated as $YY = (YY + 1) \bmod C$, and the process proceeds to step **53c**. If, however, **YY** is not equal to **M**, in a next step **53c**, the value of **Y** is set to **YY**.

Figure 6 is a block diagram, as one example among many others, representing a hardware implementation (HW) of the memory wear leveling, according to the
 20 present invention. It should be pointed out that any HW implementation is identical at the highest logical level to the software (SW) implementation or combination of HW and SW implementation as described above in regard to Figures 3, 4a, 4b and 5. The HW implementation presented here illustrates an example of specific types of modifications needed in one practical implementation. It is implemented based on a
 25 finite state machine (FSM) **15** that essentially realizes the present invention, if the solution is done using HW alone, incorporating major functional blocks **20**, **22** and **24** of Figure 3. One preferred way of doing this, among many others, is to embed the FSM **15** and glue logic to the peripheral logic functions of the memory die or macro (in case the memory is embedded in SoC chip) itself.

The m'xn' logical memory array **10a** refers to an idealized logical structure and
 30 not necessarily to the actual physical implementation, which is likely to be composed of several subarrays and may not include the actual spare block at all; the spare block

can be also located in a register, external to the actual memory array 10a. In the current example of the m'xn' logical memory array 10a the spare block is naturally included. The size of the logical array equals $C = m'xn'$ as in Figures 1a-d and the spare memory block consists of S elements (e.g., bits). Figure 3 shows that the array 10a together with some peripheral circuits including address mux/demux and array drivers 10b, R/W logic means 10c, I/O bus 10e, and sense amplifiers 10d constitute the multi-element memory 10 shown in Figure 3.

Relocation (e.g. step 52 in Figure 4a) of the block Y:Y+S (e.g., block 17 in Figures 1b) to the spare block M:M+S (e.g., block 18 in Figure 1b) for hardware implementation of the present example is done as follows. Effectively, a read signal from the block 10c is provided to the block 10a to read the data from the address Y:Y+S to the sense amplifiers 10d of the memory device, and a write signal is provided by the block 10c to write the data to the spare block address M:M+S. The addresses (Y:Y+S and M:M+S) needed for this relocation are provided to the R/W logic means 10c by the FSM 15 as described below. The I/O bus 10e and R/W logic means 10c circuits generally include buffers where the read data (block Y:Y+S) can be stored while the address is changed to M:M+S and the data written back to the array 10a. Thus, the I/O bus width/buffers should be equal in size to (or larger than) the spare block size S in the preferred HW implementation, according to the present invention.

The FSM 15, as mentioned earlier, essentially incorporates major functional blocks 20, 22 and 24 of Figure 3, according to the present invention. The timing and R/W controller 17 contains the triggering detector 20 and memory wear controller 22 with the same functions as described in regard to Figure 3. Similarly, the signals 26 (triggering signal), 27 (further triggering signal), 30 (data relocation signal) and 32 (update signal) carry the same information and have the same origin as explained in regard to Figure 3. The optional triggering detector 20 or memory wear controller 22 (if the detector 20 is not used) contains the necessary logic needed to define when a memory rotation is needed using different possible scenarios are described in regard to Figure 3. Then the data relocation signal 30 contains a read/write command signal to the R/W logic means about moving the block Y:Y+S (e.g., block 17 in Figures 1b)

to the spare block **M:M+S** (e.g., block 18 in Figure 1b). Thus the block 17 (timing and W/R controller) is responsible for determining the timing of said memory block relocation, but the information (pointer signal 34) about the locations of said memory blocks is provided to the block 17 (and then to the block 22) by the memory pointer controller 24 as disclosed in Figure 3 and further discussed below.

The normal function of the timing and R/W controller 17 is performed by a regular R/W controller 17a with an input signal, a normal memory signal 17b, which depends on the memory type (e.g., clock signal), and an output signal, a normal R/W command signal 17c to the R/W logic means 10c, which facilitates the normal R/W operations of the memory 10. The signal 17b (e.g. a clock signal) can also serve as the triggering signal 26 as discussed earlier in regard to Figure 3.

The memory pointer controller 24 effectively includes the logic and data structures needed to maintain status of the state of memory rotation and to hold the data needed for address mapping of external logic addresses to actual memory array addresses where the data requested currently resides. In particular, Y and pointer update determination means 24a, based on the updated signal from the memory wear controller 22, calculates and provides (pointer signal 34) to the timing and R/W controller 17 the physical address Y (and optionally M, if required, depending on the implementation as discussed earlier) to be accessed for enabling an at least one further data relocation of the data located at the physical address Y of the array 10a to the spare block with the address M as discussed above. After each memory relocation, means 24a updates the spare block location M in a spare block address register 24b. The spare block address information from the spare block address register 24b is used by a m'xn' address mapping counter 24c to map the correct location of the memory elements accessed by the user, who sends the address signal 24d as a part of the normal memory operation. This mapping procedure is described in details in Figures 2a-2c. Thus the block 10b (mux/demux and array drivers) receives an FSM modified address signal 24e with the correct memory address entered by the user.

It should be noted that the HW implementation is strongly dependent on the type of memory device and can be implemented using other electronic devices operating with the same fundamental logical principle but differing in details

determined by the specific memory technology. For sector addressed memories like NAND Flash, the implementation would be quite different, and a pure HW solution is probably not the preferred way. Also, if the memory cell can withstand a relatively small amount of reads or writes or erases, thousands or millions, the present invention
5 can be used with care because of the wear overhead that every cell experiences. The HW implementation is more useful if the memory can withstand several billions or more accesses/cell, because then the "hot-spot leveling" effect is dominating over the wear overhead. This makes it appealing especially to the new NVRAM type memories like FeRAM, Ovonic Unified Memory, etc. and especially read destructive
10 wearing memories (again FeRAM).